

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST  
CERTIFICATES FOR ELECTRICAL EQUIPMENT  
(IECEE) CB SCHEME

SYSTEME CEI D'ACCEPTATION MUTUELLE DE  
CERTIFICATS D'ESSAIS DES EQUIPEMENTS  
ELECTRIQUES (IECEE) METHODE OC

**CB TEST CERTIFICATE****CERTIFICAT D'ESSAI OC**

Product  
Produit

Micro-ATX motherboard

Name and address of the applicant  
Nom et adresse du demandeur

AAEON Technology Inc.  
5TH FL 135 LANE 235 PAO CHIAO RD  
HSIN-TIEN DIST NEW TAIPEI 231  
TAIWAN

Name and address of the manufacturer  
Nom et adresse du fabricant

AAEON Technology Inc.  
5TH FL 135 LANE 235 PAO CHIAO RD  
HSIN-TIEN DIST NEW TAIPEI 231  
TAIWAN

Name and address of the factory  
Nom et adresse de l'usine

INFO-TEK(SU ZHOU) ELECTRONICS CO.LTD  
P.C 215011#183 Jin feng Rd, Hi-tech Development Zone,  
SND, Suzhou , Jiangsu,  
China

Note: When more than one factory, please report on page 2  
Note: Lorsque il y plus d'une usine, veuillez utiliser la 2<sup>eme</sup> page

Additional Information on page 2

Ratings and principal characteristics  
Valeurs nominales et caractéristiques principales

(optional) +12V/15A,+5V/16A,+3.3/13A

Trademark (if any)  
Marque de fabrique (si elle existe)  
Type of Manufacturer's Testing Laboratories used  
Type de programme du laboratoire d'essais  
constructeur

AAEON

Model / Type Ref.  
Ref. De type

xIMBM-Q170Ax (x - Where x may be any combination of  
alphanumeric characters or "-" or blank for marketing purpose and  
no impact safety related critical components and constructions.)

Additional information (if necessary may also be  
reported on page 2)  
Les informations complémentaires (si nécessaire,,  
peuvent être indiqués sur la 2<sup>eme</sup> page

Additionally evaluated to EN 60950-1:2006/A11:2009/A1:2010/  
A12:2011/A2:2013; National Differences specified in the CB Test  
Report.

Additional Information on page 2

A sample of the product was tested and found  
to be in conformity with  
Un échantillon de ce produit a été essayé et a été  
considéré conforme à la

IEC 60950-1(ed.2), IEC 60950-1(ed.2);am1,  
IEC 60950-1(ed.2);am2

As shown in the Test Report Ref. No. which forms part  
of this Certificate  
Comme indiqué dans le Rapport d'essais numéro de  
référence qui constitue partie de ce Certificat

CB150916-01-A0 issued on 2015-10-15

This CB Test Certificate is issued by the National Certification Body  
Ce Certificat d'essai OC est établi par l'Organisme **National de Certification**



- UL (US), 333 Pflugsten Rd IL 60062, Northbrook, USA
- UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK
- UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN
- UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA

For full legal entity names see [www.ul.com/ncbnames](http://www.ul.com/ncbnames)

Date: 2015-10-16

Signature:

Jan-Erik Storgaard